PATENT NUMBER and ISSUE DATE

## U.S. UTILITY Patent Application

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NOTICE OF ALLOWANCE MAILED		CLAIMS ALLOWED		
	Assistant Examiner		Total Claims Print Claim O.G	
ISSUE FEE		DRAWING		
Amount Due Date Paid		Sheets Drwg.	Figs.Drwg.	Print Fig.
TERMINAL	Primary Examiner PREPARED FOR ISSUE	Application Examiner		
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